

**Notice of References Cited**

Application/Control No.

09/841,666

Applicant(s)/Patent Under  
Reexamination  
TANAKA ET AL.

Examiner

HOAN C. NGUYEN

Art Unit

2871

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	B	US-4911096	03-1990	Munakata	116/334
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	N	JP408071801A	03-1996	JP	Takeda et al.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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